



**THE DATASHEET OF
IXGR32N60CD1**

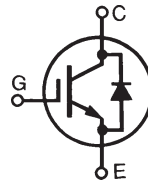


HiPerFAST™ IGBT with Diode ISOPLUS247™

IXGR 32N60CD1

$V_{CES} = 600 \text{ V}$
 $I_{C25} = 45 \text{ A}$
 $V_{CE(SAT)} = 2.7 \text{ V}$
 $t_{fi(typ)} = 55 \text{ ns}$

(Electrically Isolated Backside)

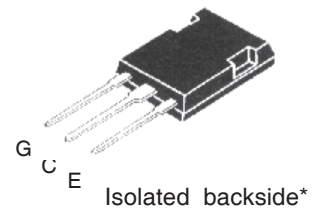


Preliminary data sheet

| Symbol | Test Conditions | Maximum Ratings | |
|---|---|----------------------------------|------------------|
| V_{CES} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}$ | 600 | V |
| V_{CGR} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}; R_{GE} = 1 \text{ M}\Omega$ | 600 | V |
| V_{GES} | Continuous | ± 20 | V |
| V_{GEM} | Transient | ± 30 | V |
| I_{C25} | $T_C = 25^\circ\text{C}$ | 45 | A |
| I_{C90} | $T_C = 90^\circ\text{C}$ | 28 | A |
| I_{CM} | $T_C = 25^\circ\text{C}, 1 \text{ ms}$ | 120 | A |
| SSOA (RBSOA) | $V_{GE} = 15 \text{ V}, T_{VJ} = 125^\circ\text{C}, R_G = 10 \Omega$ Clamped inductive load, $L = 100 \mu\text{H}$ | $I_{CM} = 64$ @ $0.8 V_{CES}$ | A |
| P_c | $T_C = 25^\circ\text{C}$ | 140 | W |
| T_J | | -55 ... +150 | $^\circ\text{C}$ |
| T_{JM} | | 150 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +150 | $^\circ\text{C}$ |
| Maximum Lead and Tab temperature for soldering 1.6 mm (0.062 in.) from case for 10 s | | 300 | $^\circ\text{C}$ |
| V_{ISOL} | 50/60 Hz, RMS $t = 1 \text{ min leads-to housing}$ | 2500 | V~ |
| Weight | | 5 | g |

ISOPLUS247™ (IXGR)

E 153432



G = Gate, C = Collector,
E = Emitter, TAB = Collector

* Patent pending

Features

- DCB Isolated mounting tab
- Meets TO-247AD package Outline
- High current handling capability
- Latest generation HDMOS™ process
- MOS Gate turn-on - drive simplicity

Applications

- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies
- AC motor speed control
- DC servo and robot drives
- DC choppers

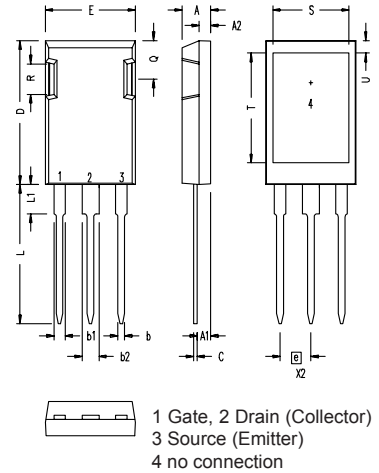
Advantages

- Easy assembly
- High power density
- Very fast switching speeds for high frequency applications

| Symbol | Test Conditions | Characteristic Values ($T_J = 25^\circ\text{C}$, unless otherwise specified) | | |
|---------------|---|---|---|---------------------------|
| | | min. | typ. | max. |
| $V_{GE(th)}$ | $I_C = 250 \mu\text{A}, V_{CE} = V_{GE}$ | 2.5 | | 5.0 V |
| I_{CES} | $V_{CE} = 600\text{V}$ $V_{GE} = 0 \text{ V}$ | | $T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$ | 200 μA 3 mA |
| I_{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$ | | | $\pm 100 \text{ nA}$ |
| $V_{CE(sat)}$ | $I_C = I_T, V_{GE} = 15 \text{ V}$ Note 1 | | 2.3 | 2.7 V |

| Symbol | Test Conditions | Characteristic Values | | | |
|---------------------------|---|---|------|----------|----|
| | | (T _J = 25°C, unless otherwise specified) | | | |
| | | min. | typ. | max. | |
| g_{fs} | I _C = I _T ; V _{CE} = 10 V, Pulse test, t ≤ 300 μs, duty cycle ≤ 2 % | | 25 | S | |
| C_{ies} | V _{CE} = 25 V, V _{GE} = 0 V, f = 1 MHz | | 2700 | pF | |
| C_{oes} | | | 240 | pF | |
| C_{res} | | | 50 | pF | |
| Q_g | I _C = I _T , V _{GE} = 15 V, V _{CE} = 0.5 V _{CES} | | 110 | nC | |
| Q_{ge} | | | 22 | nC | |
| Q_{gc} | | | 40 | nC | |
| t_{d(on)} | Inductive load, T_J = 25°C I _C = I _T , V _{GE} = 15 V, L = 100 μH, V _{CE} = 0.8 V _{CES} , R _G = R _{off} = 4.7 Ω Remarks: Switching times may increase for V _{CE} (Clamp) > 0.8 • V _{CES} , higher T _J or increased R _G | | 25 | ns | |
| t_{ri} | | | 20 | ns | |
| t_{d(off)} | | | 85 | 170 | ns |
| t_{fi} | | | 55 | | ns |
| E_{off} | | | 0.32 | 0.75 | mJ |
| t_{d(on)} | Inductive load, T_J = 125°C I _C = I _T , V _{GE} = 15 V, L = 100 μH V _{CE} = 0.8 V _{CES} , R _G = R _{off} = 4.7 Ω Remarks: Switching times may increase for V _{CE} (Clamp) > 0.8 • V _{CES} , higher T _J or increased R _G | | 25 | ns | |
| t_{ri} | | | 25 | ns | |
| E_{on} | | | 1 | | mJ |
| t_{d(off)} | | | 110 | | ns |
| t_{fi} | | | 100 | | ns |
| E_{off} | | 0.85 | | mJ | |
| R_{thJC} | | | | 0.90 K/W | |
| R_{thCK} | | | 0.15 | K/W | |

ISOPLUS 247 OUTLINE



| Dim. | Millimeter | | Inches | |
|----------------|------------|-------|----------|------|
| | Min. | Max. | Min. | Max. |
| A | 4.83 | 5.21 | .190 | .205 |
| A ₁ | 2.29 | 2.54 | .090 | .100 |
| A ₂ | 1.91 | 2.16 | .075 | .085 |
| b | 1.14 | 1.40 | .045 | .055 |
| b ₁ | 1.91 | 2.13 | .075 | .084 |
| b ₂ | 2.92 | 3.12 | .115 | .123 |
| C | 0.61 | 0.80 | .024 | .031 |
| D | 20.80 | 21.34 | .819 | .840 |
| E | 15.75 | 16.13 | .620 | .635 |
| e | 5.45 BSC | | .215 BSC | |
| L | 19.81 | 20.32 | .780 | .800 |
| L1 | 3.81 | 4.32 | .150 | .170 |
| Q | 5.59 | 6.20 | .220 | .244 |
| R | 4.32 | 4.83 | .170 | .190 |

| Symbol | Test Conditions | Characteristic Values | | |
|-------------------------|--|---|------|----------------|
| | | (T _J = 25°C, unless otherwise specified) | | |
| | | min. | typ. | max. |
| V_F | I _F = I _T , V _{GE} = 0 V, Pulse test t ≤ 300 μs, duty cycle d ≤ 2 % | | | 1.6 V 2.5 V |
| I_{RM} | I _F = I _T , V _{GE} = 0 V, -di _F /dt = 100 A/μs V _R = 100 V I _F = 1 A; -di _F /dt = 100 A/μs; V _R = 30 V | | 6 | A |
| t_{rr} | | | 100 | ns |
| | | | 25 | ns |
| R_{thJC} | | | | 1.15 K/W |

Note: 1. I_T = 32A

IXYS reserves the right to change limits, test conditions, and dimensions.

| | | | | | | | | |
|--|-----------|-----------|-----------|-----------|--------------|-------------|-------------|-----------|
| IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: | 4,835,592 | 4,931,844 | 5,049,961 | 5,237,481 | 6,162,665 | 6,404,065B1 | 6,683,344 | 6,727,585 |
| | 4,850,072 | 5,017,508 | 5,063,307 | 5,381,025 | 6,259,123B1 | 6,534,343 | 6,710,405B2 | 6,710,463 |
| | 4,881,106 | 5,034,796 | 5,187,117 | 5,486,715 | 6,306,728 B1 | 6,583,505 | | |

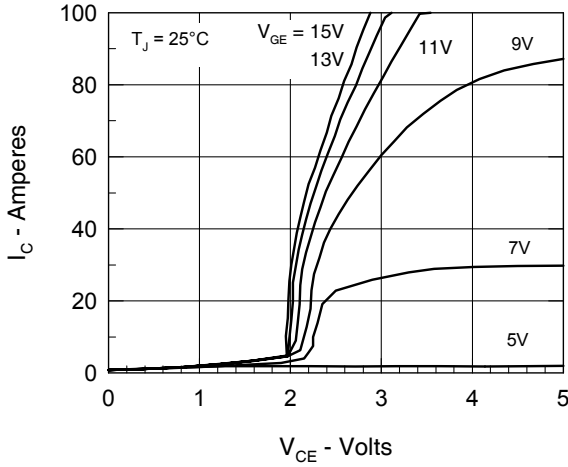


Fig. 1. Output Characteristics

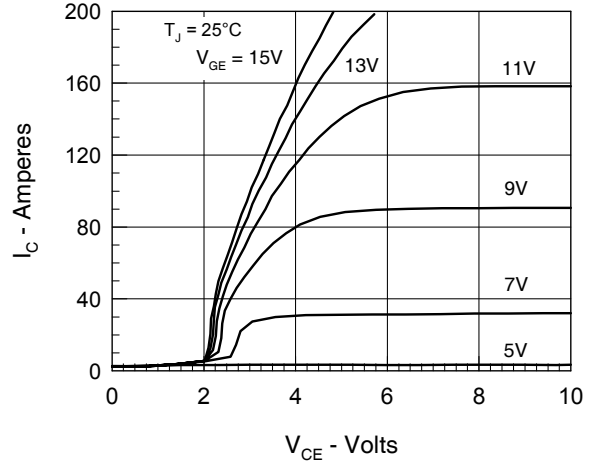


Fig. 2. Extended Output Characteristics

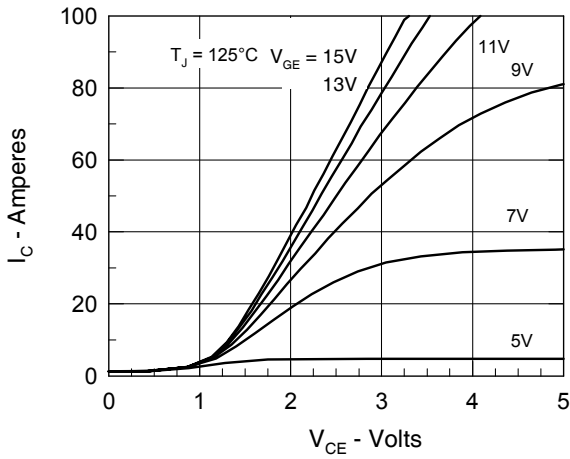


Fig. 3. High Temperature Output Characteristics

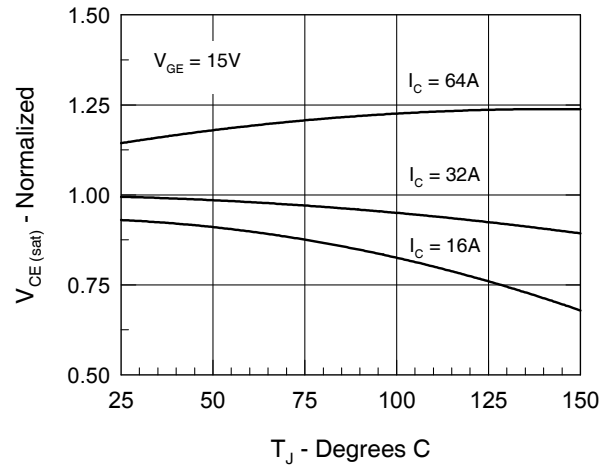


Fig. 4. Temperature Dependence of $V_{CE(sat)}$

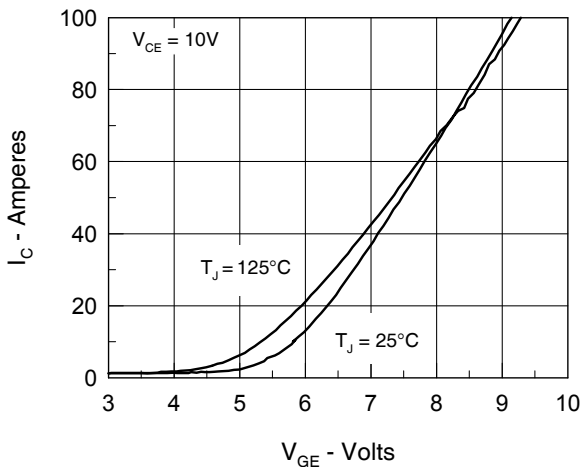


Fig. 5. Admittance Curves

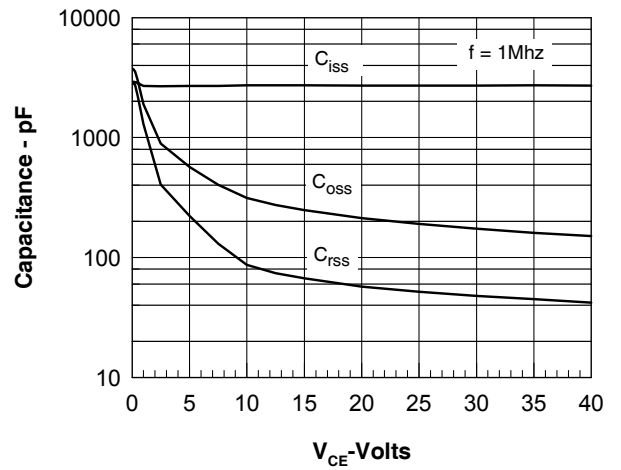


Fig. 6. Capacitance Curves

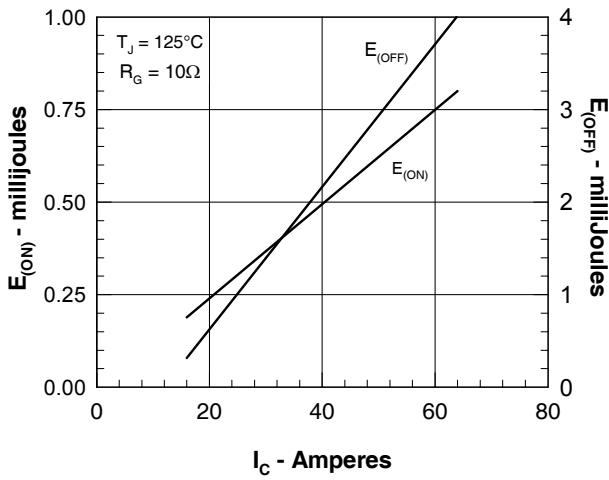


Fig. 7. Dependence of E_{ON} and E_{OFF} on I_C .

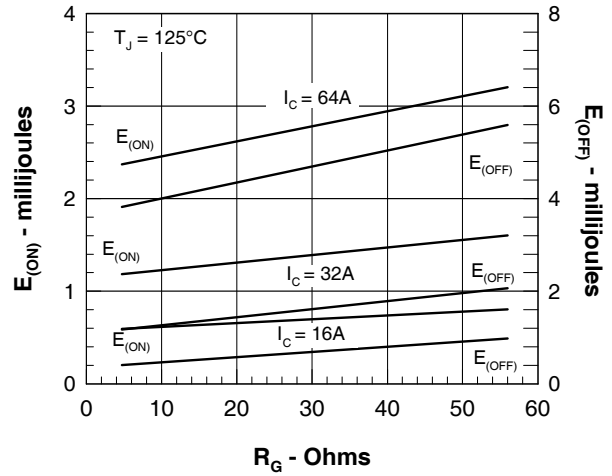


Fig. 8. Dependence of E_{ON} and E_{OFF} on R_G .

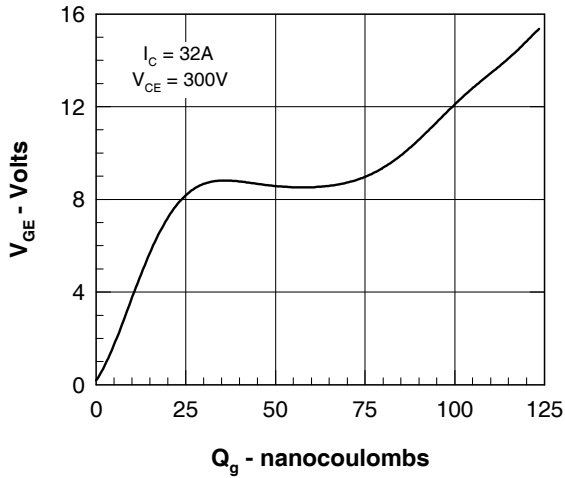


Fig. 9. Gate Charge

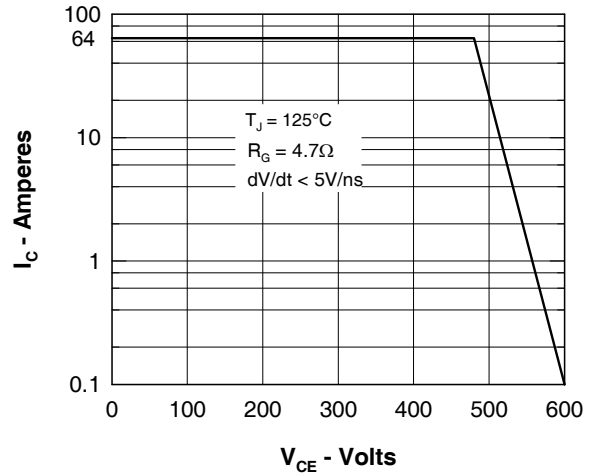


Fig. 10. Turn-off Safe Operating Area

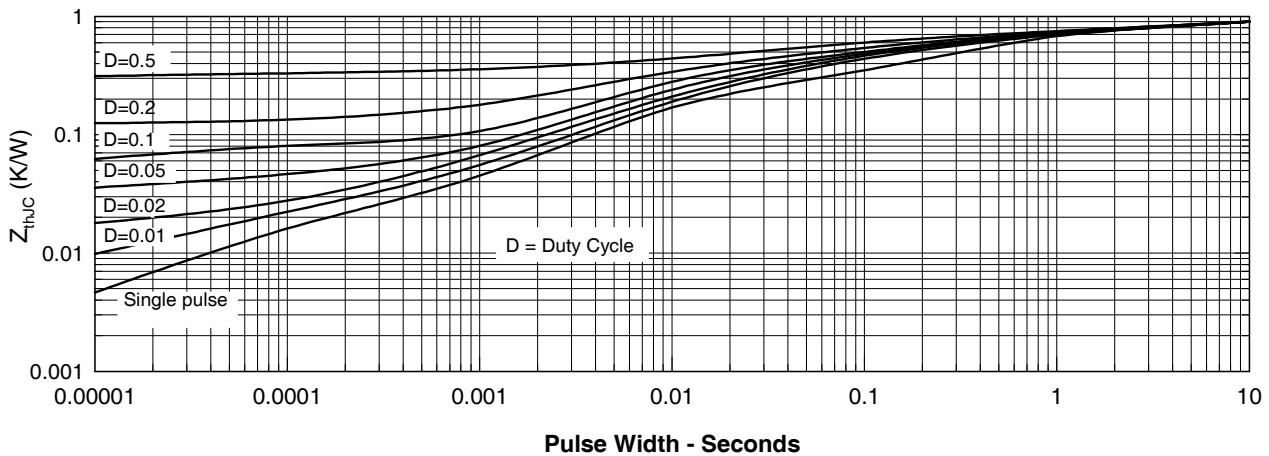


Fig. 11. Transient Thermal Resistance

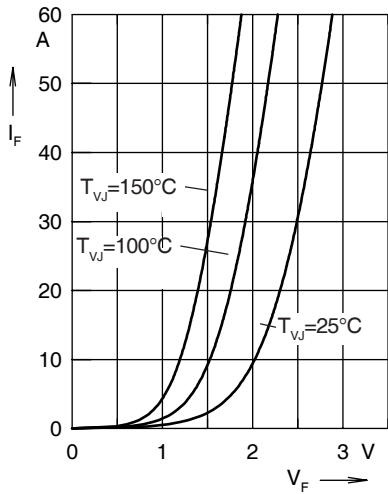


Fig. 12. Forward current I_F versus V_F

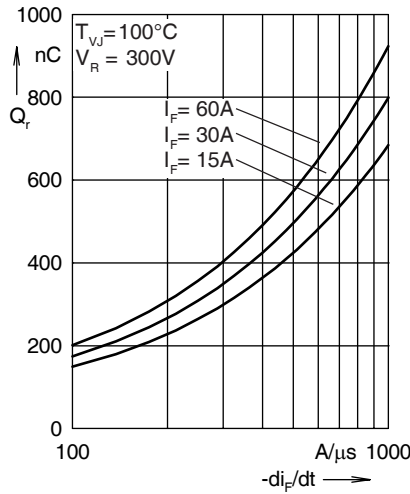


Fig. 13. Reverse recovery charge Q_r versus $-di_F/dt$

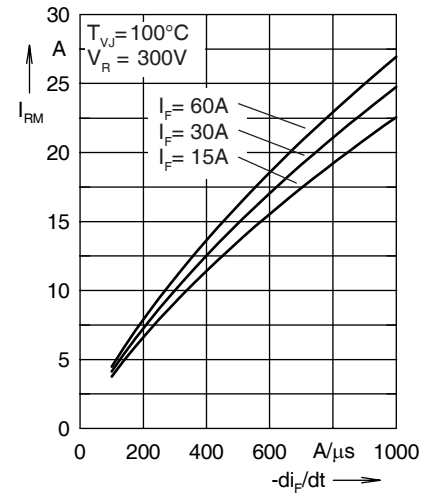


Fig. 14. Peak reverse current I_{RM} versus $-di_F/dt$

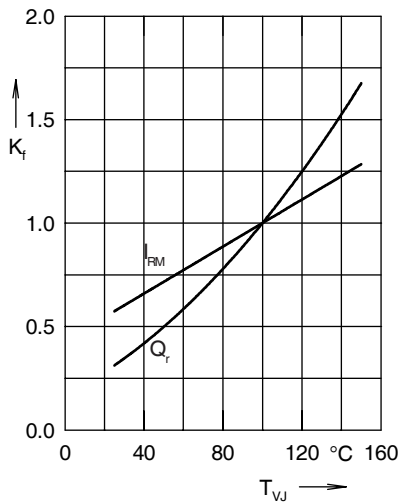


Fig. 15. Dynamic parameters Q_r , I_{RM} versus T_{VJ}

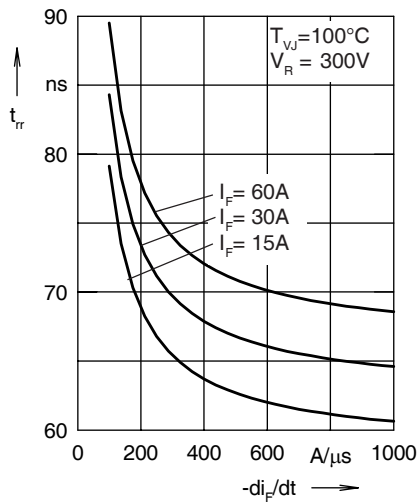


Fig. 16. Recovery time t_{tr} versus $-di_F/dt$

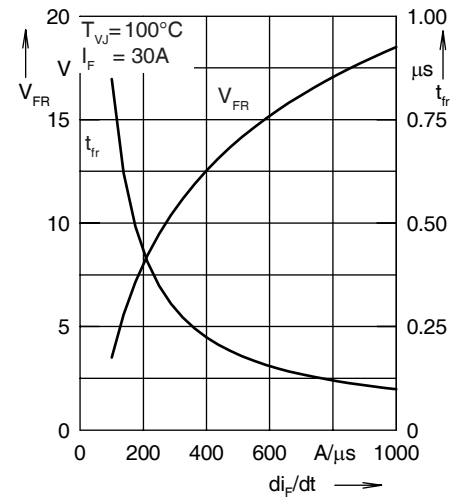


Fig. 17. Peak forward voltage V_{FR} and t_{tr} versus di_F/dt

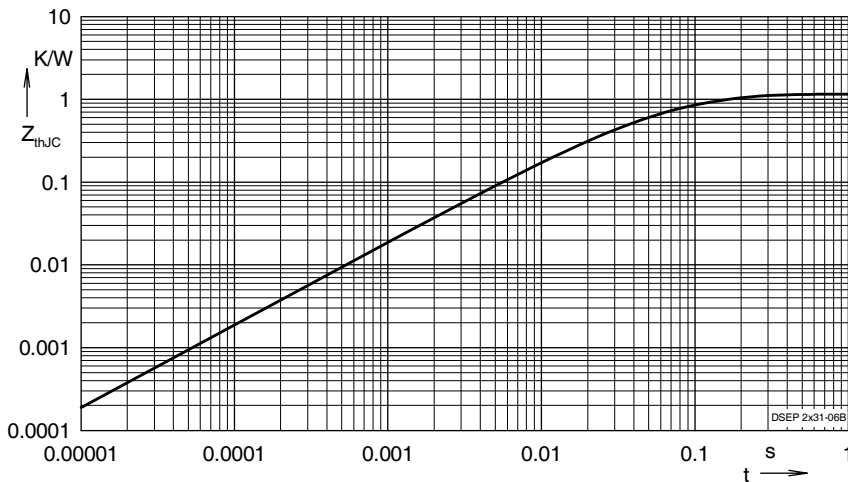


Fig. 18. Transient thermal resistance junction to case

Constants for Z_{thJC} calculation:

| i | R_{thi} (K/W) | t_i (s) |
|---|-----------------|-----------|
| 1 | 0.436 | 0.0055 |
| 2 | 0.482 | 0.0092 |
| 3 | 0.117 | 0.0007 |
| 4 | 0.115 | 0.0418 |







Looking for pricing, stock, or lifecycle information?

Click below to explore more details on WIN SOURCE:

 [View IXGR32N60CD1 on WIN SOURCE](#)

 [IXYS Information](#)

Optimize Your Supply Chain with WIN SOURCE Solutions

-  Global Sourcing Solution
-  Obsolete Management
-  Cost Control Management
-  Shortage Management
-  Alternative Solution
-  Excess Inventory Management